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**Informationstechnik –
Automatische Identifikation und Datenerfassungsverfahren –
Testspezifikation für Strichcode-Druckqualität –
2D-Symbole (ISO/IEC 15415:2004);
Englische Fassung EN ISO/IEC 15415:2005**

Information technology –
Automatic identification and data capture techniques –
Bar code print quality test specification –
Two-dimensional symbols (ISO/IEC 15415:2004);
English version EN ISO/IEC 15415:2005

Technologies de l'information –
Techniques automatiques d'identification et de capture des données –
Spécification de test de qualité d'impression des symboles de code à barres –
Symboles bi-dimensionnels (ISO/IEC 15415:2004);
Version anglaise EN ISO/IEC 15415:2005

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Nationales Vorwort

Dieses Dokument wurde vom technischen Komitee ISO/IEC/JTC 1 „Information Technology“ der Internationalen Organisationen für Normung (ISO und IEC) erarbeitet und als EN ISO/IEC 15415 vom technischen Komitee CEN/TEC 225 „Strichcodierung“ übernommen, dessen Sekretariat vom NEN gehalten wird. Das zuständige deutsche Normungsgremium ist der Normenausschuss Informationstechnik „AA 31“ Automatische Identifikation und Datenerfassungsverfahren.

DIN EN ISO/IEC 15415 beschreibt zwei Methoden für die Messung spezifischer Attribute bei zweidimensionalen Strichcode Symbolen, definiert Methoden für die Auswertung und Bewertung der Messergebnisse und stellt Informationen zur Verfügung, wodurch eventuelle Abweichungen vom Optimum verursacht werden können.

Nach den geltenden DIN-Kriterien für einen möglichen Verzicht auf die deutsche Sprachfassung wurde auf eine Übersetzung verzichtet.

English Version

Information technology – Automatic identification and data
capture techniques – Bar code print quality test specification –
Two-dimensional symbols (ISO/IEC 15415:2004)

Technologies de l'information – Techniques automatique
d'identification et de capture des données – Spécification de
test de qualité d'impression des symboles de code à barres –
Symboles bi-dimensionnels (ISO/IEC 15415:2004)

Informationstechnik – Automatische Identifikation
und Datenerfassungsverfahren – Testspezifikation für
Strichcode-Druckqualität – 2D-Symbole
(ISO/IEC 15415:2004)

This European Standard was approved by CEN on 26 August 2005.

CEN members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration. Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CEN member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CEN member into its own language and notified to the Central Secretariat has the same status as the official versions.

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Foreword

The text of ISO/IEC 15415:2004 has been prepared by Technical Committee ISO/IEC/JTC 1 "Information technology" of the International Organization for Standardization (ISO) and the International Electrotechnical Commission (IEC) has been taken over as EN ISO/IEC 15415:2005 by Technical Committee CEN/TC 225 "AIDC technologies", the secretariat of which is held by NEN.

This European Standard shall be given the status of a national standard, either by publication of an identical text or by endorsement, at the latest by March 2006, and conflicting national standards shall be withdrawn at the latest by March 2006.

According to the CEN/CENELEC Internal Regulations, the national standards organizations of the following countries are bound to implement this European Standard: Austria, Belgium, Cyprus, Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, Netherlands, Norway, Poland, Portugal, Slovakia, Slovenia, Spain, Sweden, Switzerland and United Kingdom.

Endorsement notice

The text of ISO/IEC 15415:2004 has been approved by CEN as EN ISO/IEC 15415:2005 without any modifications.

Introduction

The technology of bar coding is based on the recognition of patterns encoded, in bars and spaces or in a matrix of modules of defined dimensions, according to rules defining the translation of characters into such patterns, known as the symbology specification. Symbology specifications may be categorized into those for linear symbols, on the one hand, and two-dimensional symbols on the other; the latter may in turn be sub-divided into «multi-row bar code symbols» sometimes referred to as «stacked bar code symbols», and «two-dimensional matrix symbols». In addition there is a hybrid group of symbologies known as «composite symbologies»; these symbols consist of two components carrying a single message or related data, one of which is usually a linear symbol and the other a two-dimensional symbol positioned in a defined relationship with the linear symbol.

Multi-row bar code symbols are constructed graphically as a series of rows of symbol characters, representing data and overhead components, placed in a defined vertical arrangement to form a (normally) rectangular symbol, which contains a single data message. Each symbol character has the characteristics of a linear bar code symbol character and each row has those of a linear bar code symbol; each row, therefore, may be read by linear symbol scanning techniques, but the data from all the rows in the symbol must be read before the message can be transferred to the application software.

Two-dimensional matrix symbols are normally square or rectangular arrangements of dark and light modules, the centres of which are placed at the intersections of a grid of two (sometimes more) axes; the coordinates of each module need to be known in order to determine its significance, and the symbol must therefore be analysed two-dimensionally before it can be decoded. Dot codes are a subset of matrix codes in which the individual modules do not directly touch their neighbours but are separated from them by a clear space.

Unless the context requires otherwise, the term “symbol” in this International Standard may refer to either type of symbology.

The bar code symbol must be produced in such a way as to be reliably decoded at the point of use, if it is to fulfil its basic objective as a machine-readable data carrier.

Manufacturers of bar code equipment and the producers and users of bar code symbols therefore require publicly available standard test specifications for the objective assessment of the quality of bar code symbols (a process known as verification), to which they can refer when developing equipment and application standards or determining the quality of the symbols. Such test specifications form the basis for the development of measuring equipment for process control and quality assurance purposes during symbol production as well as afterwards.

The performance of measuring equipment for the verification of symbols (verifiers) is the subject of a separate International Standard (ISO/IEC 15426, Parts 1 and 2).

This International Standard is intended to achieve comparable results to the linear bar code symbol quality standard ISO/IEC 15416, the general principles of which it has followed. It should be read in conjunction with the symbology specification applicable to the bar code symbol being tested, which provides symbology-specific detail necessary for its application. Two-dimensional multi-row bar code symbols are verified according to the ISO/IEC 15416 methodology, with the modifications described in Clause 6; different parameters and methodologies are applicable to two-dimensional matrix symbols.

There are currently many methods of assessing bar code quality at different stages of symbol production. The methodologies described in this specification are not intended as a replacement for any current process control methods. They provide symbol producers and their trading partners with universally standardized means for communicating about the quality of multi-row bar code and two-dimensional matrix symbols after they have been printed. The procedures described in this International Standard must necessarily be augmented by the reference decode algorithm and other measurement details within the applicable symbology specification, and they may also be altered or overridden as appropriate by governing symbology or application specifications.

Alternative methods of quality assessment may be agreed between parties or as part of an application specification.

1 Scope

This part of ISO/IEC 15415

- specifies two methodologies for the measurement of specific attributes of two-dimensional bar code symbols, one of these being applicable to multi-row bar code symbologies and the other to two-dimensional matrix symbologies;
- defines methods for evaluating and grading these measurements and deriving an overall assessment of symbol quality;
- gives information on possible causes of deviation from optimum grades to assist users in taking appropriate corrective action.

This International Standard applies to those two-dimensional symbologies for which a reference decode algorithm has been defined, but its methodologies can be applied partially or wholly to other similar symbologies.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 2859-1, *Sampling procedures for inspection by attributes — Part 1: Sampling schemes indexed by acceptance quality limit (AQL) for lot-by-lot inspection*

ISO 3951, *Sampling procedures and charts for inspection by variables for percent nonconforming*

ISO 7724-2, *Paints and varnishes — Colorimetry — Part 2: Colour measurement*

ISO/IEC 15416, *Information technology — Automatic identification and data capture techniques — Bar code print quality test specification — Linear symbols*

EN 1556, *Bar Coding — Terminology*

NOTE The Bibliography lists official and industry standards containing specifications of symbologies to which (*inter alia*) this International Standard is applicable.

3 Terms and definitions

For the purposes of this document, the terms and definitions given in EN 1556 and ISO/IEC 15416 and the following apply.

3.1

binarized image

binary (black/white) image created by applying the Global Threshold to the pixel values in the reference grey-scale image

3.2

effective resolution

resolution obtained on the surface of the symbol under test, normally expressed in pixels per mm or pixels per inch, and calculated as the resolution of the image capture element multiplied by the magnification of the optical elements of the measuring device

3.3

error correction capacity

number of codewords in a symbol (or error control block) assigned for erasure and error correction, minus the number of codewords reserved for error detection

3.4

inspection area

rectangular area which contains the entire symbol to be tested inclusive of its quiet zones

3.5

grade threshold

boundary value separating two grade levels, the value itself being taken as the lower limit of the upper grade

3.6

module error

module of which the apparent dark or light state in the binarised image is inverted from its intended state

3.7

pixel

individual light-sensitive element in an array [e.g. CCD (charge coupled device) or CMOS (complementary metal oxide semiconductor) device]

3.8

raw image

plot of the reflectance values in x and y coordinates across a two-dimensional image, representing the discrete reflectance values from each pixel of the light-sensitive array

3.9

reference grey-scale image

plot of the reflectance values in x and y coordinates across a two-dimensional image, derived from the discrete reflectance values of each pixel of the light-sensitive array by convolving the raw image with a synthesised circular aperture

3.10

sample area

area of an image contained within a circle $0,8X$ in diameter, X being the average module width determined by the application of the reference decode algorithm for the symbology in question or, where the application permits a range of X dimensions, the minimum module width permitted by the application specification

3.11

scan grade

result of the assessment of a single scan of a matrix symbol, derived by taking the lowest grade achieved for any measured parameter of the reference grey-scale and binarised images

4 Symbols (and abbreviated terms)

AN = Axial Nonuniformity

E_{cap} = error correction capacity of the symbol

e = number of erasures

FPD = Fixed Pattern Damage

GN = Grid Nonuniformity

GT = Global Threshold

MOD = Modulation

R_{max} = highest reflectance in any element or quiet zone in a scan reflectance profile, or the highest reflectance of any sample area in a two-dimensional matrix symbol

R_{min} = lowest reflectance in any element in a scan reflectance profile, or the lowest reflectance of any sample area in a two-dimensional matrix symbol

SC = Symbol Contrast (equal to $R_{max} - R_{min}$)

t = number of errors

UEC = Unused Error Correction

5 Quality grading

5.1 General

The measurement of two-dimensional bar code symbols is designed to yield a quality grade indicating the overall quality of the symbol which can be used by producers and users of the symbol for diagnostic and process control purposes, and which is broadly predictive of the read performance to be expected of the symbol in various environments. The process requires the measurement and grading of defined parameters, from which a grade for an individual scan (scan reflectance profile grade or scan grade) is derived; the grades of multiple scans of the symbol are averaged to provide the overall symbol grade.

As a consequence of the use of different types of reading equipment under differing conditions in actual applications, the levels of quality required of two-dimensional bar code symbols to ensure an acceptable level of performance will differ. Application specifications should therefore define the required performance in terms of overall symbol grade in accordance with this standard, following the guidelines in Annex D.4.

The sampling method should be based on a statistically valid sample size within the lot or batch being tested. A minimum overall symbol grade for acceptability shall be established prior to quality control inspection. In the absence of a sampling plan defined in formal quality assurance procedures or by bilateral agreement, a suitable plan may be based on the recommendations in ISO 2859 or ISO 3951.

5.2 Expression of quality grades

Although this International Standard specifies a numeric basis for expressing quality grades on a descending scale from 4 to 0, with 4 representing the highest quality, individual parameter grades and individual scan grades may also be expressed on an equivalent alphabetic scale from A to D, with a failing grade of F, in application standards with a historical link to ANSI X3.182.

Table 1 maps the alphabetic and numeric grades to each other.

Table 1 — Equivalence of numeric and alphabetic quality grades

Numeric grade	Alphabetic Grade
4	A
3	B
2	C
1	D
0	F

5.3 Overall Symbol Grade

The overall symbol grade shall be calculated as defined in 6.2.6 or 7.10. Overall symbol grades shall be expressed to one decimal place on a numeric scale ranging in descending order of quality from 4,0 to 0,0.

Where a specification defines overall symbol grades in alphabetic terms the relative mapping of the alphabetic and numeric grades is as illustrated in Figure 1 below. For example, the range of 1,5 to immediately below 2,5 corresponds to grade C.

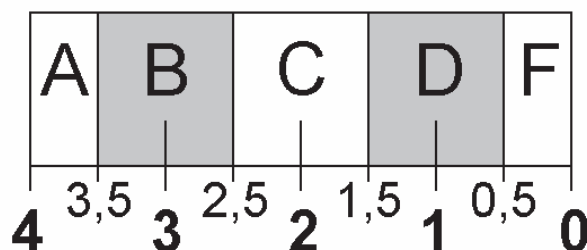


Figure 1 — Mapping of alphabetic and numeric overall symbol grades

5.4 Reporting of symbol grade

A symbol grade is only meaningful if it is reported in conjunction with the illumination and aperture used. It should be shown in the format *grade/aperture/light/angle*, where:

- "*grade*" is the overall symbol grade as defined in 6.2.6 or 7.10, i.e. the arithmetic mean to one decimal place of the scan reflectance profile or scan grades,
- "*aperture*" is the aperture reference number [from ISO/IEC 15416 for linear scanning techniques, or the diameter in thousandths of an inch (to the nearest thousandth) of the synthetic aperture defined in 7.3.3],
- "*light*" defines the illumination: a numeric value indicates the peak light wavelength in nanometres (for narrow band illumination); the alphabetic character W indicates that the symbol has been measured with broadband illumination ("white light") the spectral response characteristics of which must imperatively be defined or have their source specification clearly referenced,
- "*angle*" is an additional parameter defining the angle of incidence (relative to the plane of the symbol) of the illumination. It shall be included in the reporting of the overall symbol grade when the angle of incidence is other than 45°. Its absence indicates that the angle of incidence is 45°.

NOTE This International Standard provides for 30° and 90° illumination in addition to the default 45°.

An asterisk following the value for "grade", in the case of a two-dimensional matrix symbol, indicates that the surroundings of the symbol contain extremes of reflectance that may interfere with reading - see 7.6.

EXAMPLES

2,8/05/660 would indicate that the average of the grades of the scan reflectance profiles, or of the scan grades, was 2,8 when these were obtained with the use of a 0,125 mm aperture (ref. no. 05) and a 660 nm light source, incident at 45°.

2,8/10/W/30 would indicate the grade of a symbol intended to be read in broadband light, measured with light incident at 30° and using a 0,250 mm aperture (ref. no. 10), but would need to be accompanied either by a reference to the application specification defining the reference spectral characteristics used for measurement or a definition of the spectral characteristics themselves.

2,8*/10/670 would indicate the grade of a symbol measured using a 0,250 mm aperture (ref. no. 10), and a 670 nm light source, and indicates the presence of a potentially interfering extreme reflectance value in the surroundings of the symbol.

6 Measurement methodology for two-dimensional multi-row bar code symbols

6.1 General

The evaluation of two-dimensional multi-row bar code symbols shall be based on the application of the methodology of ISO/IEC 15416, modified as described in 6.2.2 or 6.3, and if appropriate for the symbology, on the application of the additional provisions described in 6.2.3, 6.2.4 and 6.2.5, to derive an overall symbol grade. Ambient light levels shall be controlled in order not to have any influence on the measurement results. The symbol shall be scanned using the light wavelength(s) and effective aperture size specified in the appropriate application standard. When performing a measurement, the scan lines should be made perpendicular to the height of the bars in the start and stop characters and should as far as possible pass through the centres of rows in order to minimize the effect of cross-talk from adjacent rows. In the case of area imaging techniques, a number of scan lines, perpendicular to the height of the bars and sufficient to cover all rows of the symbol, shall be synthesized by convolving the raw image with the appropriate synthetic aperture.

6.2 Symbologies with cross-row scanning ability

6.2.1 Basis of grading

The distinguishing feature of these symbologies is their ability to be read with scan lines that cross row boundaries. Symbologies of this type, at the date of publication of this International Standard, also share the feature that the start and stop patterns (or equivalent features of the symbol, e.g. the Row Address Patterns of MicroPDF417) are constant from row to row, or the position of only one edge in these patterns varies by no more than 1X in adjacent rows of the symbol. These symbologies shall be graded in respect of:

- Analysis of the scan reflectance profile (based on ISO/IEC 15416) (see 6.2.2)
- Codeword Yield (see 6.2.3)
- Unused Error Correction (see 6.2.4)
- Codeword print quality (see 6.2.5)

6.2.2 Grade based on analysis of scan reflectance profile

The start and stop or equivalent (e.g. Row Address) patterns of the symbol shall be evaluated according to ISO/IEC 15416. Regions with data content will be evaluated separately as described in 6.1.2, 6.1.3 and 6.1.4. Test scans of the Start and Stop patterns shall be graded using all parameters specified in ISO/IEC 15416. The effective aperture size is specified in the appropriate application standard or is the default aperture size appropriate for the symbol X dimension given in ISO/IEC 15416.

For the analysis of the scan reflectance profiles, the number of scans should be ten, or the height of the symbol divided by the measuring aperture. If this quotient is less than ten scans should be approximately evenly spaced over the height of the symbol. For example, in a twenty-row symbol the ten scans might be performed in alternate rows. In a two-row symbol, up to five scans might be performed in each row, at different positions in the height of the bars. The symbology specification may give more specific guidance on the selection of the scans to be used.

To identify bars and spaces, a Global Threshold for each scan has to be determined. Global Threshold shall be equal in reflectance to $(R_{max} + R_{min}) / 2$, where the values R_{max} and R_{min} are respectively the highest and the lowest reflectances in the scan. All regions above the Global Threshold shall be considered spaces (or quiet zones) and all regions below shall be considered bars.

Edge locations shall be determined as the points where the reflectance value is midway between the highest reflectance in the adjoining space and the lowest reflectance in the adjoining bar, in accordance with ISO/IEC 15416.

For the evaluation of the parameters 'decode' and 'decodability' the reference decode algorithm for the symbology shall be applied.

Each scan shall be graded as the lowest grade for any individual parameter in that scan. The grade based on scan reflectance profiles shall be the arithmetic mean of the grades for the individual scans.

The measurement of bar width gain or loss may be used for process control purposes. Note that this method will not be sensitive to printing variations parallel to the height of the start and stop characters. If a full analysis of the printing process is desired, symbols should be printed and tested in both orientations.

6.2.3 Grade based on Codeword Yield

This parameter measures the efficiency with which linear scans can recover data from a two-dimensional multi-row symbol. The Codeword Yield is the number of validly decoded codewords expressed as a percentage of the maximum number of codewords that could have been decoded (after adjusting for tilt). A poor Codeword Yield, for a symbol whose other measurements are good, may indicate a Y-axis print quality problem (such as those shown in Table C.1).

Obtain a matrix of the correct symbol character values, such as would result from successful completion of the UEC calculations (see 6.2.4). This matrix is used as the "final decode of the symbol" used in subsequent steps to determine validly decoded codewords.

An individual scan qualifies for inclusion in the Codeword Yield calculation if it meets either of two conditions:

- 1) The scan did not include recognised portions of either the top or the bottom row of the symbol. At least one of the Start or Stop (or Row Address) patterns shall have been successfully decoded from that scan, together with at least one additional codeword or the corresponding second Start or Stop pattern, or Row Address Pattern.
- 2) The scan included recognised portions of either the top or the bottom row of the symbol. Both the Start and Stop patterns of the symbol shall have been successfully decoded from that scan.

It is important to note that an extension to the symbology's Reference Decode Algorithm is required, in order to detect and decode a pair of Start and Stop patterns when neither of the adjacent codewords is decodable. As examples, a linear search for a matching pair of PDF417 Start and Stop patterns, or a linear search for a matching pair of MicroPDF417 Row Indicator Patterns, would fulfil this requirement for scans where the Reference Decode Algorithm alone did not decode both patterns; thus this extension can qualify a scan where no codewords (other than the matched end patterns) were decoded. Note however, that a scan that contains only a *single* decoded Start or Stop pattern found by this linear search does not count as a qualified scan, if no other codewords or corresponding second Start or Stop pattern, or Row Address Pattern, were also decoded.

Decode the symbol completely and populate the symbol matrix.

For each qualified scan, compare the codewords actually decoded with the codewords in the symbol matrix and count the number of codewords that match. Accumulate the total number of validly decoded codewords, and update a count of the number of times each codeword of the symbol has been decoded and a count of the number of times each row has been detected. Also record a count of the number of detected row crossings in each scan (a crossing is "detected" when a scan line yields correctly-decoded codewords from adjacent rows).

After processing each scan, calculate the maximum number of codewords that could have been decoded thus far, as the number of qualified scans multiplied by the number of columns in the symbol (excluding the fixed patterns, such as the Start and Stop patterns of PDF417 or the Row Address Indicators of MicroPDF417).

The entire symbol shall be scanned multiple times until three conditions are met:

- 1) the maximum number of codewords that could have been decoded is at least ten times the number of codewords in the symbol,
- 2) the highest and lowest decodable rows (which may not necessarily be the first and last rows) of the symbol have each been scanned at least three times, and
- 3) at least $(0,9n)$ of the codewords (data or error correction) have been successfully decoded two or more times, where n is the number of non-error-correction data codewords in the symbol.

EXAMPLE Taking a PDF417 symbol with 6 rows and 16 columns and error correction level 4, the total number of codewords is 96, of which 64 are data and 32 error correction. To fulfil condition 1, the maximum number of codewords that could have been decoded must be at least 960. To fulfil condition 3, since n is 64, at least 58 of the codewords must have been decoded twice or more ($0,9 \times 64 = 57,6$).

If the ratio of the total number of validly decoded codewords to the total number of detected row crossings is less than 10 : 1, then discard the measurements just obtained, and repeat the measurement process, adjusting the tilt angle of the scan line to reduce the number of row crossings.

Otherwise, to compensate for any residual tilt, subtract the number of detected row crossings from the calculated maximum number of codewords that could have been decoded.

Codeword Yield shall be graded as shown in Table 2:

Table 2 — Grading of Codeword Yield

Codeword Yield	Grade
$\geq 71 \%$	4
$\geq 64 \%$	3
$\geq 57 \%$	2
$\geq 50 \%$	1
$< 50 \%$	0

6.2.4 Grade based on unused error correction

Decode the symbol completely and process scans until the number of decoded codewords stabilizes. Calculate the unused error correction (UEC) as $UEC = 1,0 - ((e + 2t) / E_{cap})$, where e = the number of erasures, t = the number of errors and E_{cap} = the error correction capacity of the symbol (the number of error correction codewords minus the number of error correction codewords reserved for error detection). If no error correction has been applied to the symbol, and if the symbol decodes, $UEC = 1$. If $(e + 2t)$ is greater than E_{cap} , $UEC = 0$. In symbols with more than one (e.g. interleaved) error correction block, UEC shall be calculated for each block independently and the lowest value shall be used for grading purposes.

Unused Error Correction shall be graded as shown in Table 3:

Table 3 — Grading of Unused Error Correction

Unused Error Correction	Grade
$\geq 0,62$	4
$\geq 0,50$	3
$\geq 0,37$	2
$\geq 0,25$	1
$< 0,25$	0

6.2.5 Grade based on codeword print quality

The approach detailed in this subclause provides additional diagnostic information and enables allowance to be made for the effect of error correction in masking less than perfect attributes of the symbol that influence symbol quality, by applying an overlay technique as described in Annex F. It enables the Decodability, Defects and Modulation parameters of scan reflectance profiles covering the entire data region of the symbol to be graded in accordance with ISO/IEC 15416.

This approach uses the following procedure for the assessment of each of the three parameters. In symbols with more than one (e.g. interleaved) error correction block, it shall be applied to each block independently and the lowest value shall be used for grading purposes.

The entire symbol shall be scanned until $0.9n$ codewords (where n has the same meaning as in 6.2.3) have been decoded ten times or until it is certain that each codeword has been scanned at least once without inter-row interference. In each scan, the Decodability, Defects and Modulation parameters shall be measured in each symbol character in accordance with ISO/IEC 15416. The calculation of all three parameters shall be based on the value of Symbol Contrast obtained from R_{max} and R_{min} in that scan line. For each scan, the lowest of the three parameter values for each codeword in that scan is the codeword grade for that codeword on that scan. The interim codeword grade for each codeword is the highest codeword grade obtained on any scan for that codeword.

Where the rows include overhead characters (other than the Start and Stop, or equivalent patterns), for example Row Indicators in PDF417 symbols, that are not included in the error correction calculation, these overhead characters shall be assessed first for each row together with the corresponding characters from the rows immediately above and below the row being considered. The highest interim codeword grade for any of these six (or four, in the case of the top or bottom row) characters shall be the overhead grade used to moderate the interim codeword grades for the codewords in the row. If a data codeword's interim codeword grade is higher than the grade obtained by the overhead characters, the data codeword's interim codeword grade shall be reduced to the overhead grade. The interim parameter grades so obtained shall then be modified to allow for the influence of error correction, as described below.

For each parameter, the cumulative number of symbol characters achieving each grade from 4 to 0 or a higher grade, and those not decoded, shall be counted, and the counts shall be compared with the error correction capacity of the symbol as follows:

For each grade level, assuming that all symbol characters not achieving that grade or a higher grade are erasures, derive a notional grade for Unused Error Correction as described in 6.2.4, based on the percentage thresholds shown in Table 3. The codeword parameter grade shall be the lower of the grade level and the notional UEC grade.

NOTE 1 This notional grade is not related to, and does not affect, the UEC grade for the symbol as calculated according to 6.2.4, but is a means of compensating for the extent to which error correction can mask imperfections in a symbol. If one symbol has higher error correction capacity than another symbol, then the former symbol can tolerate a greater number of codewords with poor values for the parameter in question than the latter. See Annex F for a fuller description of the approach. The final codeword parameter grade for the symbol shall be the highest codeword interim grade for all grade levels.

Table 4 shows an example of grading one parameter in a symbol containing 100 symbol characters (codewords) with an error correction capacity of 32 codewords. The 100 codewords consist of 68 data codewords, 3 error correction codewords reserved for error detection, and 29 error correction codewords to be used for correcting erasures or errors, giving an erasure correction capacity of 29. The symbol would be graded 1 for the parameter concerned (the highest value in the right-hand column).

NOTE 2 A similar calculation is performed for each of the parameters Modulation, Defects and Decodability

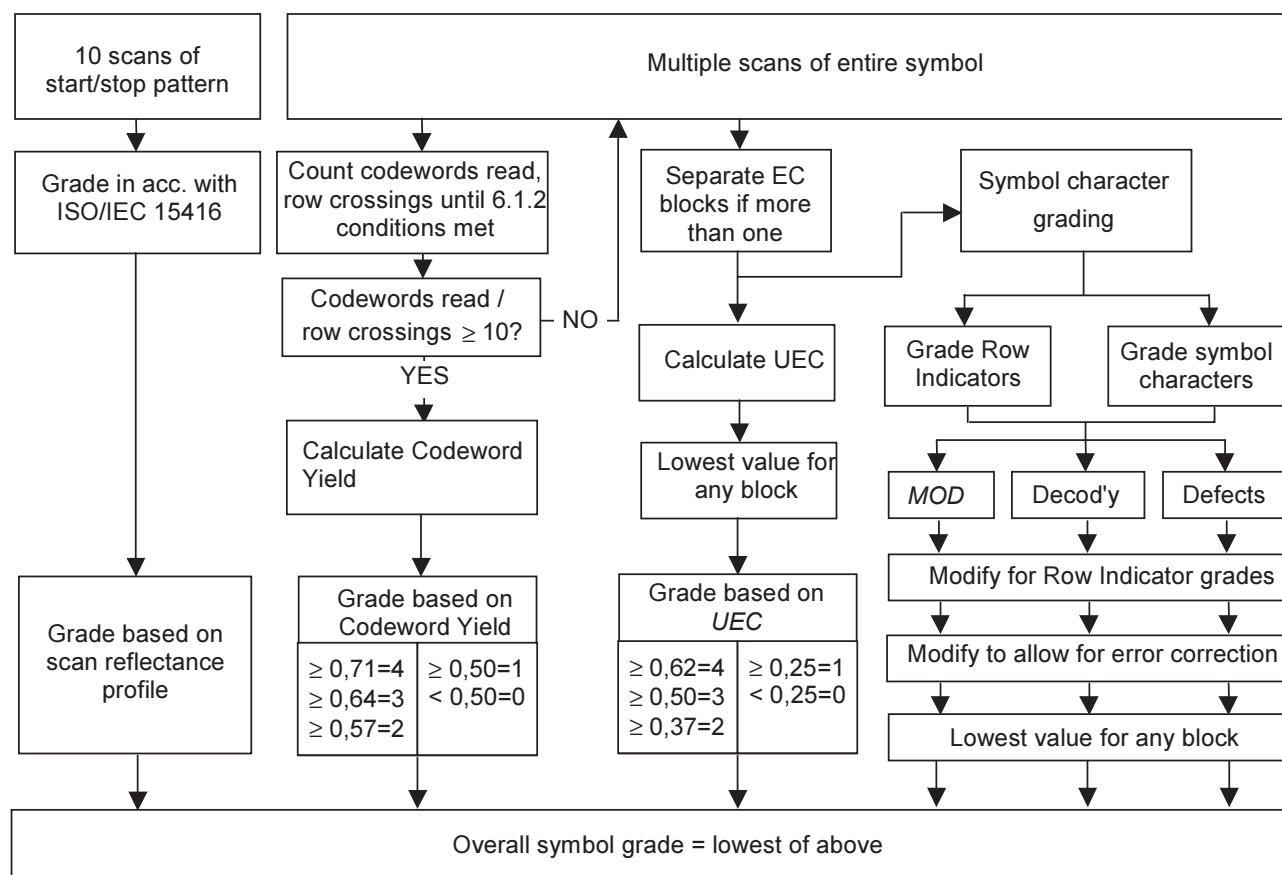
Table 4 — Example of codeword print quality parameter grading in symbols with cross-row scanning ability, applying overlay procedure in Annex F

<i>MOD/Defects/Decodability</i> grade level (a)	No. of codewords at level a	Cumulative no. of codewords at level a or higher (b)	Remaining codewords (treated as erasures) (100 - b) (c)	Notional unused error correction capacity (29 - c)	Notional UEC (%)	Notional UEC grade (d)	Codeword interim grade level (Lower of a or d) (e)
4	40	40	60	(exceeded)	< 0	0	0
3	20	60	40	(exceeded)	< 0	0	0
2	10	70	30	(exceeded)	< 0	0	0
1	10	80	20	9	31 %	1	1
0	7	87	13	16	55 %	3	0
Not decoded	13	100					
					Parameter grade (Highest value of e)		1

6.2.6 Overall symbol grade

The overall symbol grade shall be the lowest of the grade based on analysis of the scan reflectance profile in accordance with 6.2.2, and the grades based on Codeword Yield, Unused Error Correction and codeword print quality in accordance with 6.2.3, 6.2.4 and 6.2.5.

The flowchart in Figure 2 summarizes the process.

**Figure 2 — Grading process for multi-row symbols with cross-row scanning ability**

6.3 Symbolologies requiring row-by-row scanning

The distinguishing feature of these symbolologies is that they require a scan line to traverse a complete row from start to stop pattern (or in the reverse direction) without crossing into an adjacent row and that they require all rows to be scanned.

Each row shall be evaluated in accordance with ISO/IEC 15416 as though it were a separate symbol. Scan lines shall pass through the inspection band of the central 80 % of the height of each row, as specified in ISO/IEC 15416, in order to minimize the effects of cross-talk from adjacent rows. The number of scans per row should be the lower of ten, or the row height divided by the aperture diameter. The overall symbol grade shall be the lowest overall grade obtained for any row.

7 Measurement methodology for two-dimensional matrix symbols

7.1 Overview of methodology

The measurement methodology defined in this clause is designed to maximize the consistency of both reflectivity and dimensional measurements of symbols on various substrates. The basis of this methodology is the measurement of reflectance from the symbol. This methodology is also intended to correlate with conditions encountered in two-dimensional matrix scanning systems.

The method starts by obtaining the raw image, which is a high-resolution grey-scale image of the symbol captured under controlled illumination and viewing conditions. The stored raw image is then converted into a reference grey-scale image, by convolving the raw image with a synthetic circular aperture. From the reference grey-scale image, the Symbol Contrast, Modulation and Fixed Pattern Damage parameters are measured and graded. A secondary binarized image is produced from the reference grey-scale image by applying a Global Threshold, and this binarized image is then analysed and graded for the parameters of Decode, Axial Nonuniformity, Grid Nonuniformity, and Unused Error Correction, together with any additional parameters defined in the symbology or application specification. The methodology recognizes possible extreme reflectance values in the neighbourhood of the symbol, which might interfere with reading; however, only their presence is indicated in the report of the overall symbol grade.

In addition, print growth or loss is measured along each axis of the symbol and reported as an ungraded process control measurement.

The scan grade is the lowest grade achieved for these seven parameters and any others specified for a given symbology or application, and the overall symbol grade is the arithmetic mean of the individual scan grades for a number of tested images of the symbol.

7.2 Obtaining the test images

7.2.1 Measurement conditions

A test image of the symbol shall be obtained in a configuration that mimics the typical scanning situation for that symbol, but with substantially higher resolution (see 7.3.3), uniform illumination, and at best focus. The reference optical arrangement is defined in 7.3.4 and should be used where application requirements do not call for a specialized optical arrangement; alternative optical arrangements (two of which are defined in 7.3.4) may be used provided that the measurements obtained with them can be correlated with the use of the reference optical arrangement.

Measurements shall be made with light of a single peak wavelength or set of spectral characteristics and a known diameter of measuring aperture, both of which shall be defined by the application specification or determined in accordance with 7.3.2 and 7.3.3. Ambient light levels shall be controlled in order not to have any influence on the measurement results.

Whenever possible, measurements shall be made on the symbol in its final configuration, i.e. the configuration in which it is intended to be scanned. The measurement method is described in 7.6 and Annex B, and is intended to prevent extreme reflectance values outside the symbol area (e.g. when surrounded by free air or a highly specularly reflective surface) from distorting the symbol contrast measurements.